ICO9 Rec'd PCT/PTO FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE (REV. 7-80) PATENT AND TRADEMARK OFFICE 5033,1014 To Be Assigned APPLICANT LIST OF PRIOR ART CITED BY APPLICANT Frank SCHREIBER FILING DATE GROUP (Use several sheets if necessary) To Be Assigned Herewith **U.S. PATENT DOCUMENTS** FILING DATE EXAMINER INITIAL SUB-IF APPROPRIATE DOCUMENT NUMBER DATE NAME CLASS CLASS /AN/ A01 6,459,484 Oct. 1, 2002 Yokoi 356 318 2002/0176162 /AN/ A02 Nov. 28, 2002 Borlinghaus 432 359 A03 A04 A05 A06 A07 80A A09 A10 FOREIGN PATENT DOCUMENTS SUB-CLASS DOCUMENT NUMBER COUNTRY CLASS TRANSLATION /AN/ A11 WO 95/07447 Mar. 16, 1995 WO-WIPO See abstract See abstract of corresponding /AN/ WO 95/07447; see Intl. Search A12 DE 43 30 347 Mar. 16, 1995 DE-Germany Report /AN/ See abstract; see Intl. Search DE 199 02 625 A13 Sep. 30, 1999 **DE-Germany** Report A14 A15 A16 A17 A18 A19 OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.) A20 International Search Report for PCT/DE2004/000255 (3 pages) /AN Wolfgang BECKER et al.: "Lifetime Imaging Techniques for Optical Microscopy", Online!, Feb. 2003, XP-A21 002290246, http://www.becker-hickl.de/pdf/tcvgbh1.pdf, retrieved from the Internet on 26 July 2004, pp. 1-41 Holger BIRK et al.: "Programmable beam-splitter for confocal laser scanning microscopy", International Society for A22 Optical Engineering, U.S.A., Proceedings of SPIE, Vol. 4621, May 2002, XP-002290245, pp. 16-27 **A23**

/Abdullahi Nur/ 04/07/2007 **EXAMINER DATE CONSIDERED** *EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.